

表面輪廓儀 EZSTEP



型號：EZSTEP

特色：

1. 機構簡單穩定
2. 實驗室之檢測利器
3. 可依顧客需求訂製其他特殊規格

Specification

Vertical measuring range	40 μm
Vertical measuring resolution	1 nm
Horizontal scanning range	30 μm
Horizontal scanning resolution	0.1 μm
Sample diameter	≤ 30 mm
Sample thickness	≤ 10 mm
Probe tip radius	$\leq 1\mu\text{m}$
Probe material	Diamond coated tungsten
One touch scan	Yes
Step analysis	Yes
Roughness analysis	Yes
Raw data export	Yes (text, excel, and matlab)
Targeting microscopic camera	Embedded
Basic vibration isolator	Yes

若您對此產品有興趣，歡迎來信或來電洽詢，我們將派專人為您服務！

原力精密儀器 Force Precision Instrument Co., Ltd.

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